


<b>Search Notes</b>  	<b>Application/Control No.</b>  10511333	<b>Applicant(s)/Patent Under Reexamination</b>  HIRANO ET AL.
	<b>Examiner</b>  TRI H PHAN	<b>Art Unit</b>  2416

SEARCHED			
Class	Subclass	Date	Examiner
370	338, 465-469	4/7/2008	TP
709	223-226	4/7/2008	TP

SEARCH NOTES		
Search Notes	Date	Examiner
Frank Duong (consulted search)	4/4/2008	TP
EAST (USPT,JPO,EPO,FPRS,DWPI) - see text search history printout.	4/7/2008	TP
Inventorship search	10/17/08	TP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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